Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/791,798	CHOI ET AL.	
Examiner	Art Unit	
Sang Nguyen	2877	

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Class	Subclass	Date	Examiner
356	237.1- 237.5	4/26/2006	SN
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l l	121-127		
250	225		
	216		
	363.3		
324	753		
	770		1
382	141	l	V
	154	4/26/2006	SN

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
same as	above	4/25/06	GN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST Searched for Interference Print oOut	4/26/2006	SN			
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